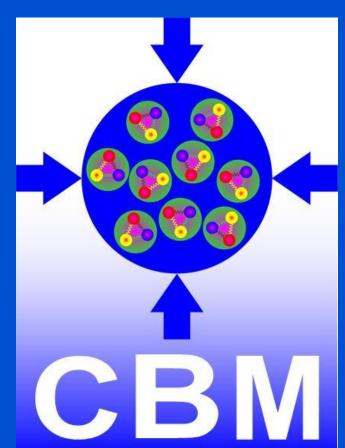
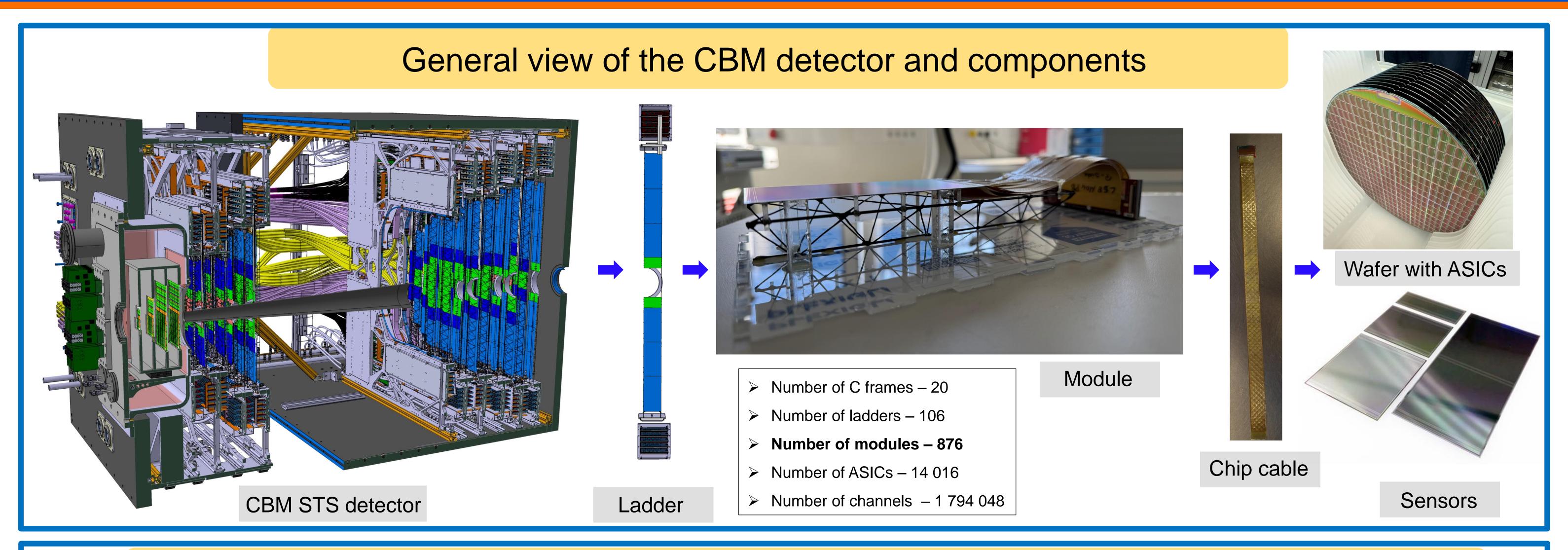
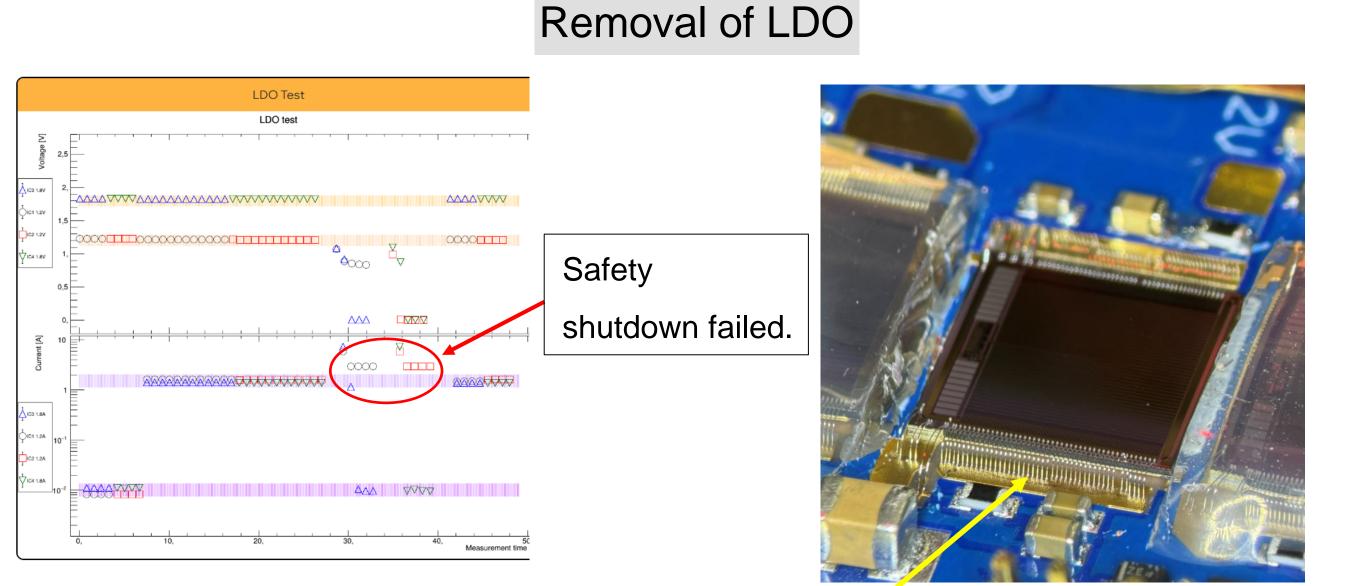
Successes to rework CBM-STS detector ladders and modules

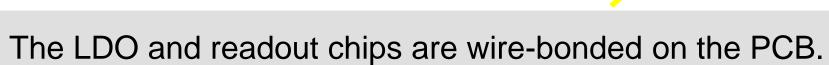
GSI, for the MT annual meeting

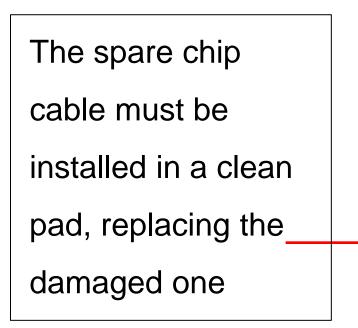


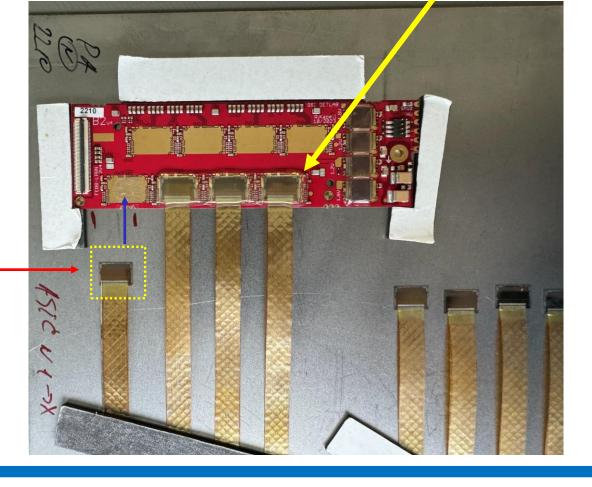


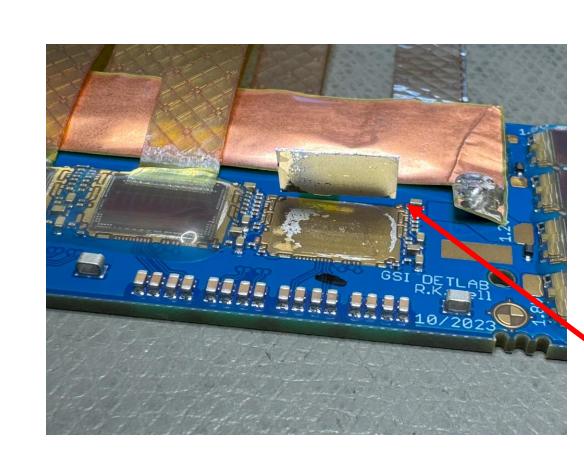
The assembly and repair process at each stage of module production



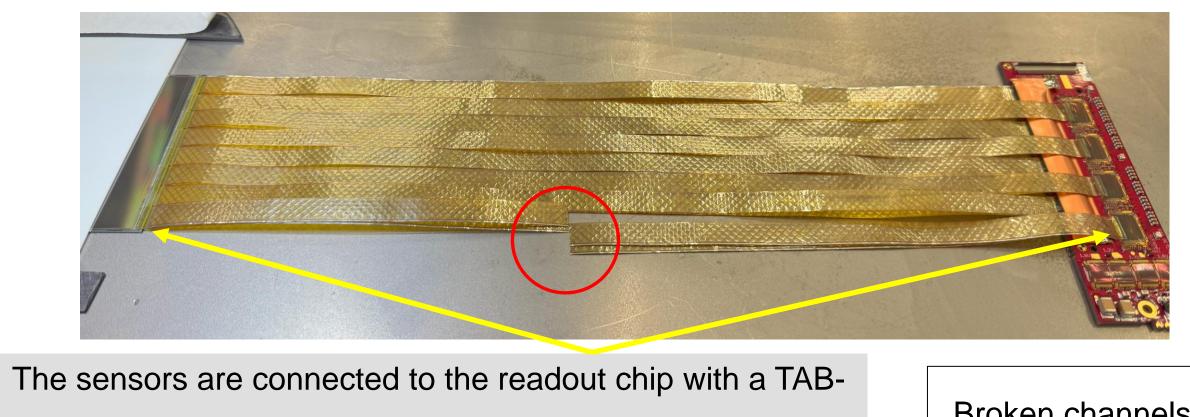




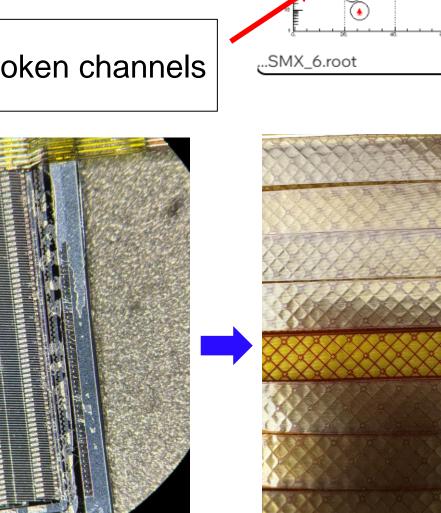




Removal of chip cable with multiple damaged channels



Broken channels

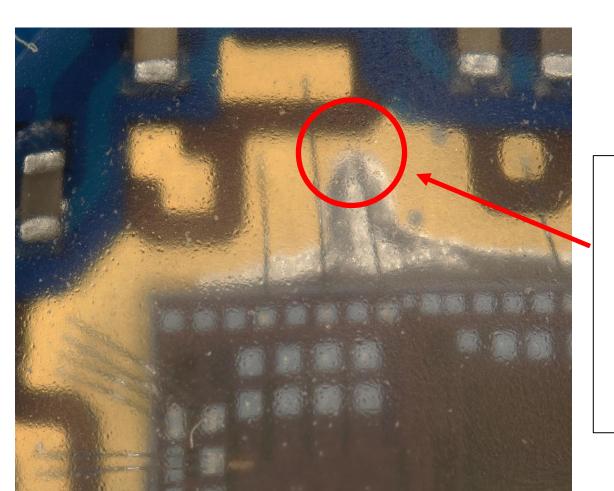


Removing the chip cable from the sensor surface and removing glue residue

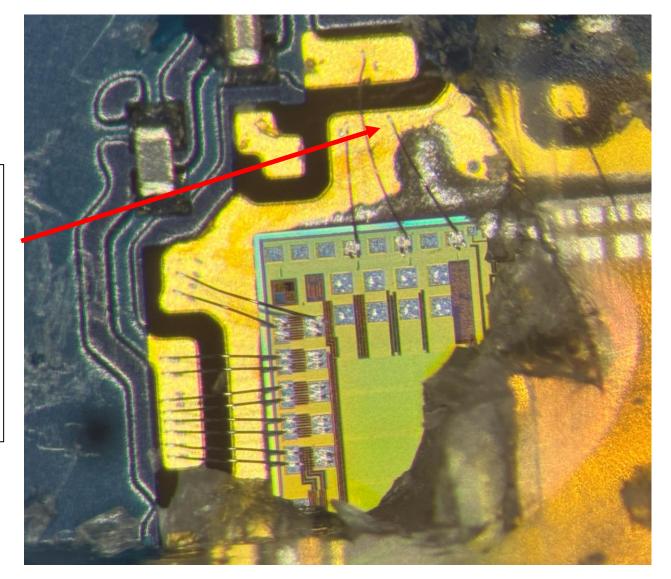
bonded micro cable.

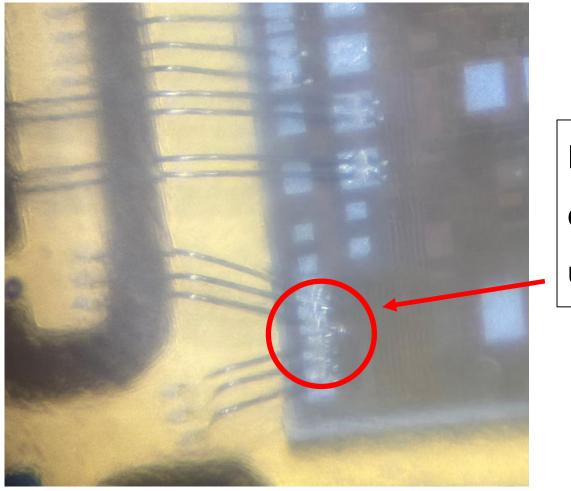
Removing the damaged readout ASIC.

Repairing damaged connections under the glob top.

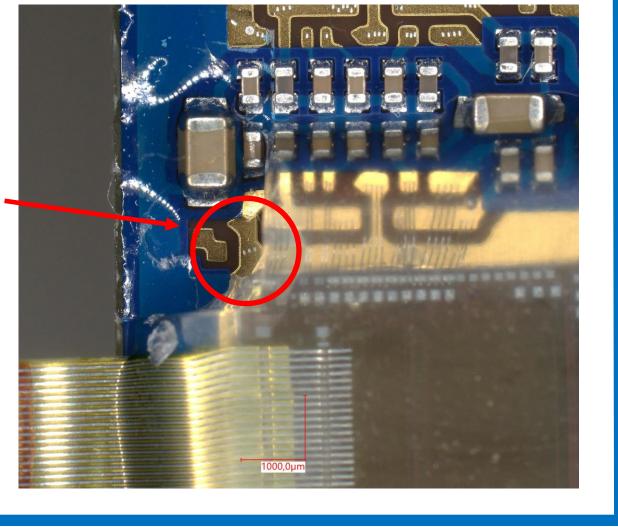


Removing glue and restoring damaged contact



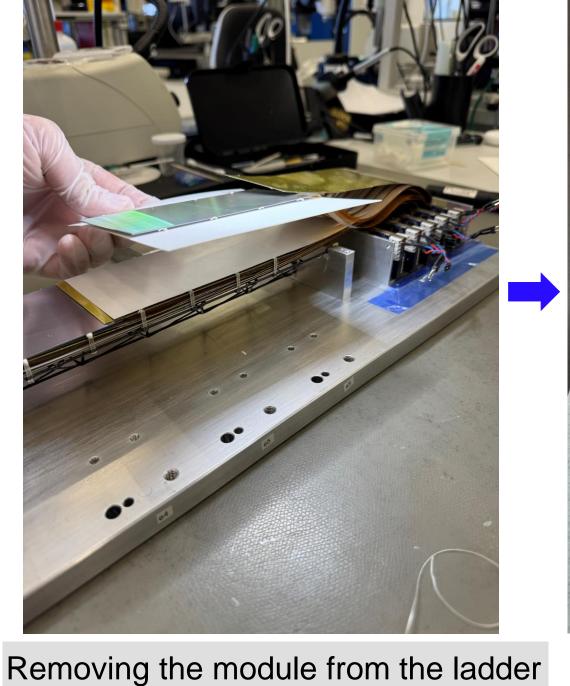


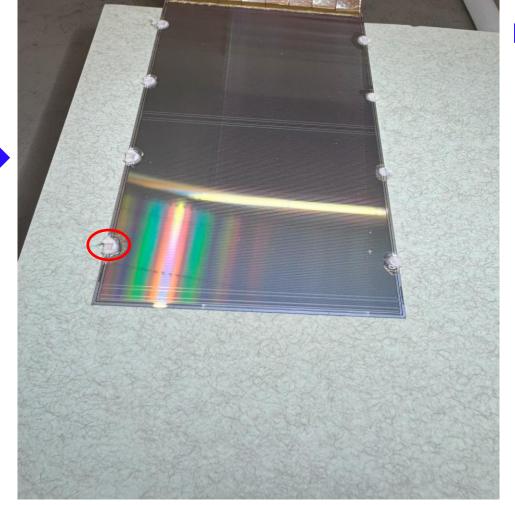
Fixing a short circuit on a chip under glop top



Removing the damaged module from the ladder and scraping the glue off the sensor surface







Removing silicone glue

